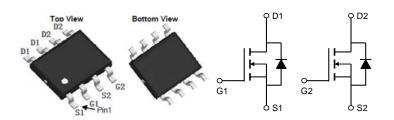


General Description

The KSP4812 series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible onresistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

SOP-8 Pin Configuration



Product Summary

V _{DS} (V)	$R_{DS(on)}$ (m Ω)	I _D (A)
30	20 at VGS = 10 V	6.8
30	28 at V _{GS} = 4.5 V	5.1

Features

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current

Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
	Drain Current – Continuous (Tc=25°C)	6.8	А
D	Drain Current – Continuous (Tc=100℃)	3.9	А
DM	Drain Current – Pulsed¹	30	А
P _D	Power Dissipation (Tc=25°C)	1.25	W
	Power Dissipation (Tc=100℃)	0.05	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		51	°C/W
Rejc	Thermal Resistance Junction to Case		7.4	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted) Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
IDSS	Drain-Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =25°C			1	uA
		V _{DS} =30V , V _{GS} =0V , T _J =125℃			15	uA
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20 V$, V_{DS} = $0 V$			±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V , I_D =5A		20	26	mΩ
		V _{GS} =4.5V , I _D =4A		28	38	mΩ
$V_{\text{GS(th)}}$	Gate Threshold Voltage	V_{GS} = V_{DS} , I_D =250uA	1.0	1.5	3.0	V
gfs	Forward Transconductance	V_{DS} =5 V , I_{S} =5 A		20		S

Dynamic and switching Characteristics

Q_g	Total Gate Charge		 8	
Q_{gs}	Gate-Source Charge	V_{DS} =15V , V_{GS} =5V , I_{D} =6A	 1.8	 nC
Q_{gd}	Gate-Drain Charge		 2.2	
$T_{d(on)}$	Turn-On Delay Time		 7	
Tr	Rise Time	Vps=15V,RL=6Ω	 5	 ns
$T_{d(off)}$	Turn-Off Delay Time	V _G s=10V,R _G =6Ω	 18	 113
T_f	Fall Time		 5	
Ciss	Input Capacitance		 420	
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , F=1MHz	 78	 pF
C_{rss}	Reverse Transfer Capacitance		 52	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			6	Α
lsм	Pulsed Source Current				15	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V

Note:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics (Curves)

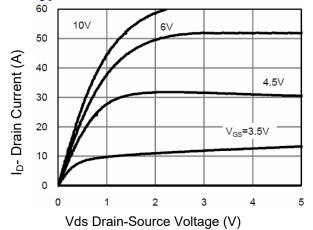


Fig.1 Output Characteristics

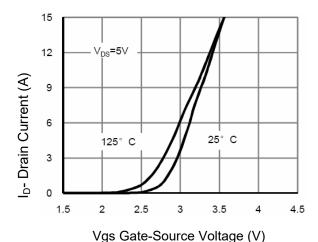


Fig. 2 Transfer Characteristics

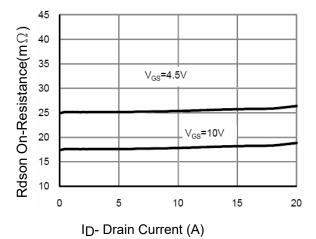


Fig. 3 Rdson- Drain Current

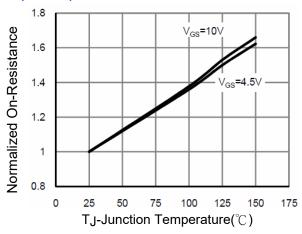


Fig. 4 Rdson-JunctionTemperature

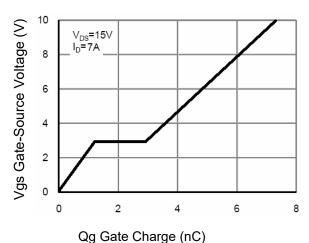


Fig. 5 Gate Charge

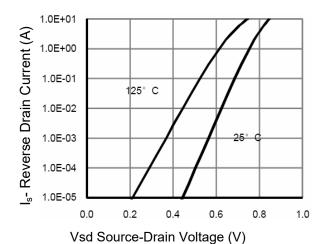
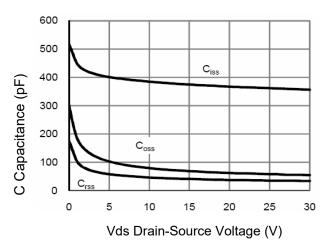


Fig. 6 Source- Drain Diode Forward





Figu.7 Capacitance vs Vds

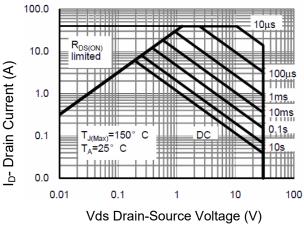


Fig.9 Safe Operation Area

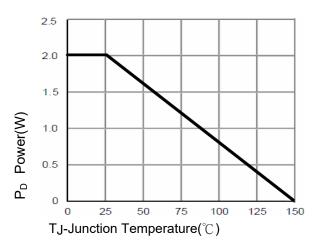


Fig. 8 Power Dissipation

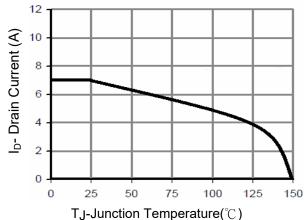


Fig. 10 V_{GS(th)} vs Junction Temperature

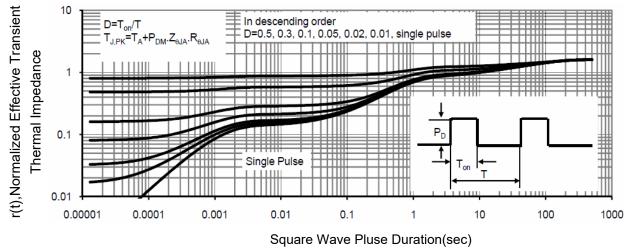


Fig.11 Normalized Maximum Transient Thermal Impedance



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